

## N-Channel MOSFET

### Features:

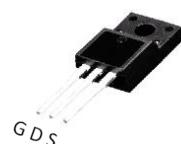
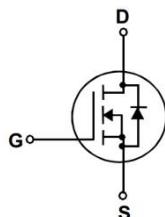
- RoHS Compliant
- Low RDS(on) & FOM
- Excellent stability and uniformity
- Extremely low switching loss
- Peak Current vs Pulse Width Curve

### Applications:

- Adaptor
- Charger
- Lighting
- Power Supply

|                                  |       |
|----------------------------------|-------|
| $V_{DSS}(\text{Min.})$           | 650V  |
| $R_{DS(\text{ON})}(\text{Typ.})$ | 0.75Ω |
| $I_D$                            | 10A   |

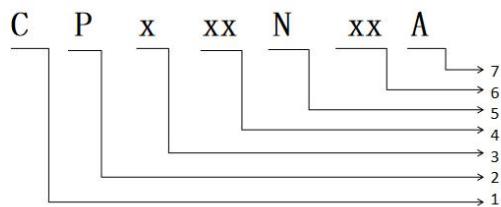
### Schematic and Package Information:



**TO-220F  
CPF10N65A**

### Marking on the body:

#### VD MOSFET tube naming rules



- 1: CYS for short
- 2: P - plane MOS
- 3: Package
 

|            |               |           |
|------------|---------------|-----------|
| F: TO-220F | P: TO-220     | D: TO-252 |
| U: TO-251  | W: TO-247S/3P | E: SOP-8  |
| G: DFN5*6  | K: DFN3.3*3.3 |           |
- 4: Current (above 200V)
- 5: N: N channel P: P channel
- 6: Maximum breakdown voltage (10% of BVdss)
- 7: Series no.

### Absolute Maximum Ratings $T_C=25^\circ\text{C}$ unless otherwise specified

| Parameter                                                  | Symbol              | CPx10N65A       |  | Units                     |
|------------------------------------------------------------|---------------------|-----------------|--|---------------------------|
|                                                            |                     | TO-220F         |  |                           |
| Drain-to-Source Voltage                                    | $V_{DSS}$           | 650             |  | V                         |
| Continuous Drain Current                                   | $I_D$               | 10              |  | A                         |
| Pulsed Drain Current, $V_{GS}@10\text{V}$ (NOTE *1)        | $I_{DM}$            | 40              |  | A                         |
| Power Dissipation                                          | $P_D$               | 40              |  | W                         |
| Derating Factor above $25^\circ\text{C}$                   |                     | 0.32            |  | $\text{W}/^\circ\text{C}$ |
| Gate-to-Source Voltage                                     | $V_{GS}$            | $\pm 20$        |  | V                         |
| Single Pulse Avalanche Energy ( $L=10\text{mH}$ )          | $E_{AS}$            | 500             |  | mJ                        |
| Peak Diode Recovery $dv/dt$                                | $dv/dt$             | 5               |  | V/ns                      |
| Maximum Temperature for Soldering                          | $T_L$               | 300             |  | $^\circ\text{C}$          |
| Operating Junction and Storage Temperature Range (NOTE *2) | $T_J$ and $T_{STG}$ | 150, -55 to 150 |  |                           |

**Thermal Resistance**

| Parameter           | Symbol           | Typ.    |  | Units |
|---------------------|------------------|---------|--|-------|
|                     |                  | TO-220F |  |       |
| Junction to Case    | R <sub>θJC</sub> | 3.13    |  | °C/W  |
| Junction to Ambient | R <sub>θJA</sub> | 62.5    |  | °C/W  |

**Electrical Characteristics** TJ=25°C unless otherwise specified

| Parameter                            | Symbol               | Min. | Typ. | Max. | Units | Test Conditions                                                     |
|--------------------------------------|----------------------|------|------|------|-------|---------------------------------------------------------------------|
| Drain-to-Source Breakdown Voltage    | BV <sub>DSS</sub>    | 650  | --   | --   | V     | V <sub>GS</sub> =0V, I <sub>D</sub> =250μA                          |
| Gate Threshold Voltage               | V <sub>GS(TH)</sub>  | 2    | 3    | 4    | V     | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA            |
| Static Drain-to-Source On-Resistance | R <sub>DSS(ON)</sub> | --   | 0.75 | 0.9  | Ω     | V <sub>GS</sub> =10V, I <sub>D</sub> =5A                            |
| Drain-to-Source Leakage Current      | I <sub>DSS</sub>     | --   | --   | 1    | uA    | V <sub>DS</sub> =650V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =25°C  |
|                                      |                      | --   | --   | 100  |       | V <sub>DS</sub> =520V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =125°C |
| Gate-to-Source Forward Leakage       | I <sub>GSS</sub>     | --   | --   | +100 | nA    | V <sub>GS</sub> =+30V                                               |
| Gate-to-Source Reverse Leakage       |                      | --   | --   | -100 |       | V <sub>GS</sub> = -30V                                              |
| Forward Transconductance(NOTE *3)    | g <sub>f</sub>       | --   | 9.5  | --   | S     | V <sub>DS</sub> =15V, I <sub>D</sub> =5A                            |

**Dynamic Characteristics** Essentially independent of operating temperature

| Parameter                       | Symbol              | Min. | Typ. | Max. | Units | Test Conditions                                                                        |
|---------------------------------|---------------------|------|------|------|-------|----------------------------------------------------------------------------------------|
| Input Capacitance               | C <sub>iss</sub>    | --   | 1500 | --   | pF    | V <sub>GS</sub> =0V, V <sub>DS</sub> =25V<br>f = 1.0MHz                                |
| Output Capacitance              | C <sub>oss</sub>    | --   | 125  | --   |       |                                                                                        |
| Reverse Transfer Capacitance    | C <sub>rss</sub>    | --   | 4.46 | --   |       |                                                                                        |
| Total Gate Charge               | Q <sub>g</sub>      | --   | 30.3 | --   | nC    | ID=10A, VDD=520V<br>VGS = 10V                                                          |
| Gate-to-Source Charge           | Q <sub>gs</sub>     | --   | 8    | --   |       |                                                                                        |
| Gate-to-Drain ("Miller") Charge | Q <sub>gd</sub>     | --   | 12   | --   |       |                                                                                        |
| Turn-on Delay Time              | t <sub>d(ON)</sub>  | --   | 27   | --   |       |                                                                                        |
| Rise Time                       | t <sub>rise</sub>   | --   | 22   | --   | ns    | V <sub>DD</sub> =325V, I <sub>D</sub> =10A,<br>V <sub>G</sub> =10V R <sub>G</sub> =10Ω |
| Turn-Off Delay Time             | t <sub>d(OFF)</sub> | --   | 53   | --   |       |                                                                                        |
| Fall Time                       | T <sub>fall</sub>   | --   | 24   | --   |       |                                                                                        |

**Source-Drain Diode Characteristics** T<sub>C</sub>=25°C unless otherwise specified

| Parameter                                     | Symbol          | Min. | Typ. | Max. | Units | Test Conditions                                                                              |
|-----------------------------------------------|-----------------|------|------|------|-------|----------------------------------------------------------------------------------------------|
| Continuous Drain-Source Diode Forward Current | I <sub>S</sub>  | --   | --   | 10   | A     | T <sub>C</sub> =25°C                                                                         |
| Pulsed Drain-Source Diode Forward Current     | I <sub>SM</sub> | --   | --   | 40   |       |                                                                                              |
| Diode Forward Voltage                         | V <sub>SD</sub> | --   | --   | 1.5  | V     | I <sub>SD</sub> =5A, V <sub>GS</sub> =0V<br>I <sub>F</sub> = I <sub>S</sub><br>di/dt=100A/us |
| Reverse Recovery Time                         | t <sub>rr</sub> | --   | 528  | --   |       |                                                                                              |
| Reverse Recovery Charge                       | Q <sub>rr</sub> | --   | 3220 | --   | nC    |                                                                                              |

Notes:

1. T<sub>J</sub> = +25°C to +150°C.
2. Repetitive rating; pulse width limited by maximum junction temperature.
3. Pulse width < 380μs; duty cycle < 2%.

## Typical Characteristics

Figure 1. Typical Output Characteristics

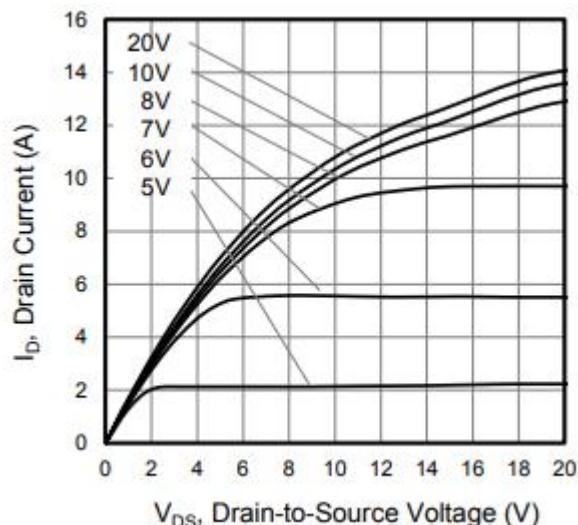


Figure 2. Body Diode Forward Voltage

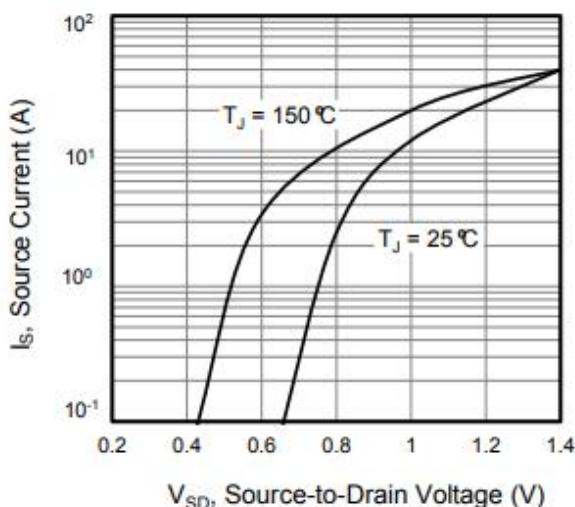


Figure 3. Drain Current vs. Temperature

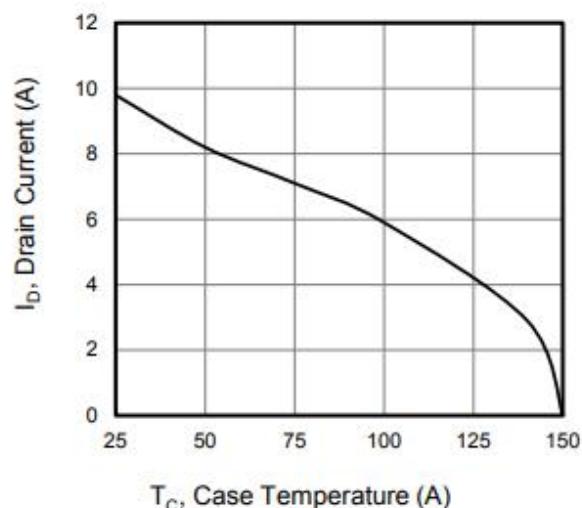


Figure 4. Power Dissipation vs. Temperature

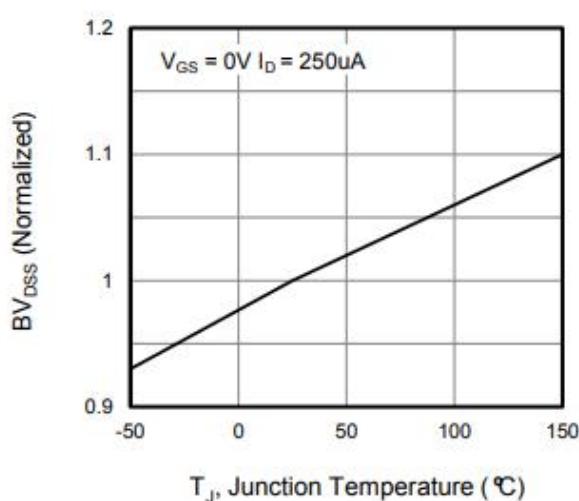


Figure 5. Transfer Characteristics

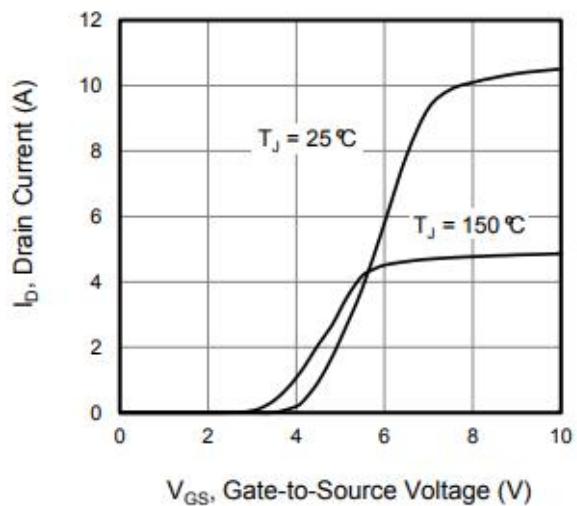


Figure 6. On-Resistance vs. Temperature

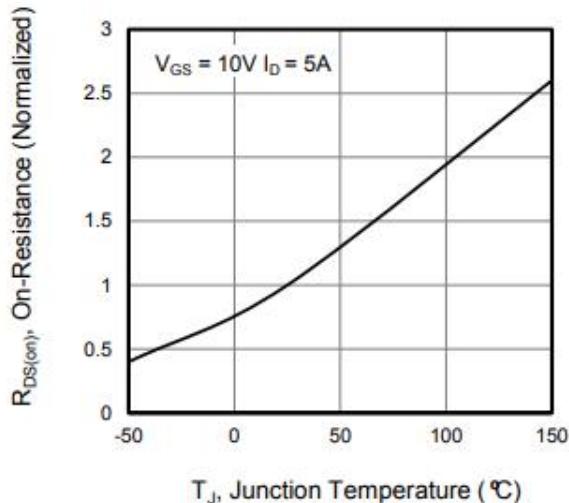


Figure 7. Capacitance

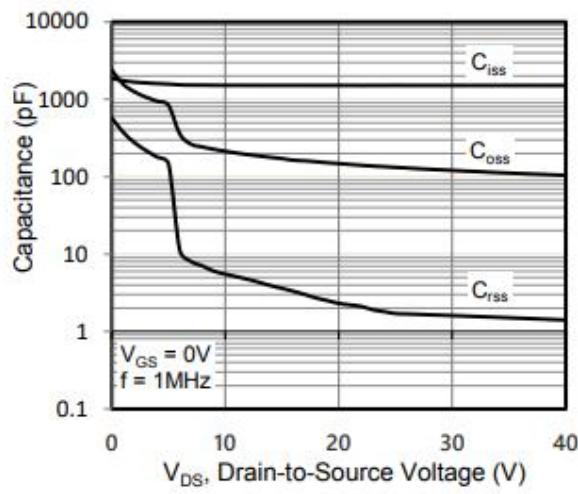


Figure 8. Gate Charge

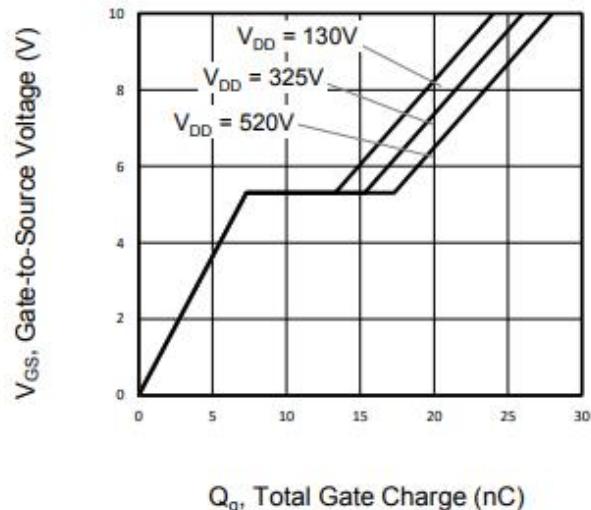
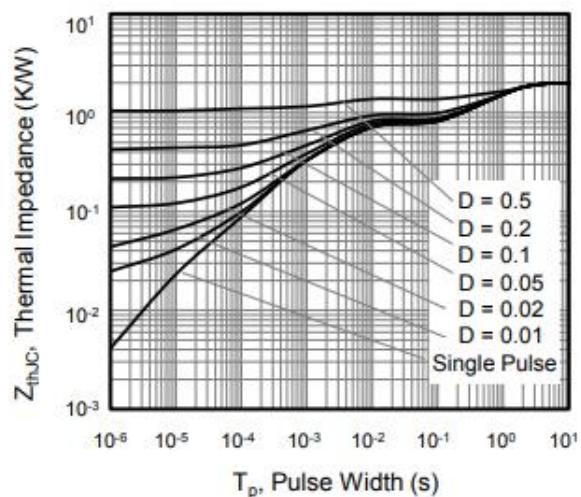
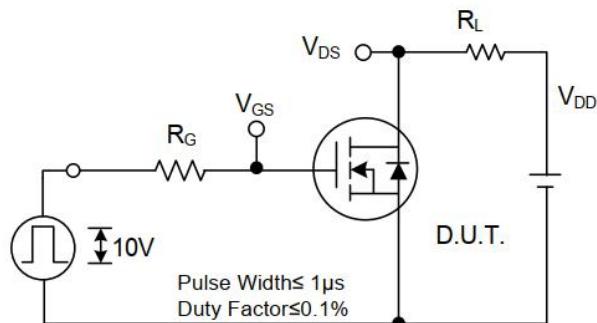


Figure 9. Transient Thermal Impedance

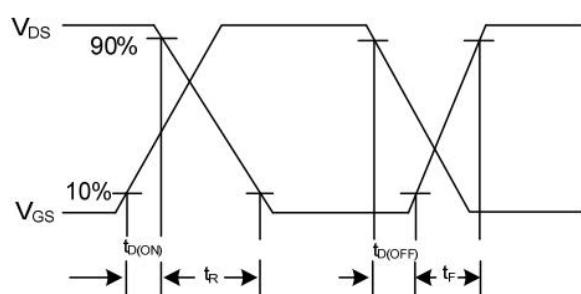
TO-220F



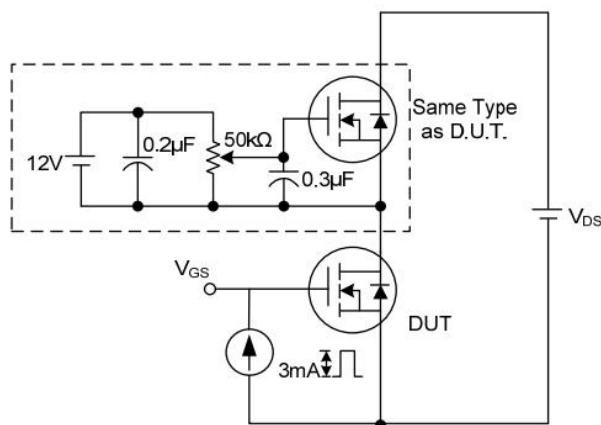
### Test Circuits and Waveforms



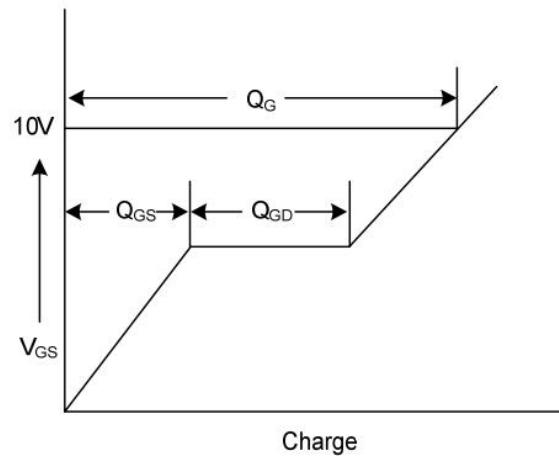
Switching Test Circuit



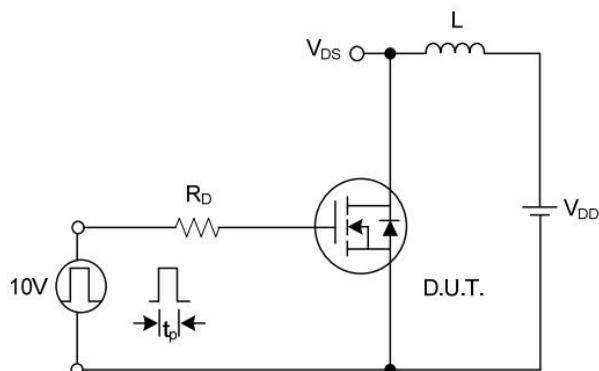
Switching Waveforms



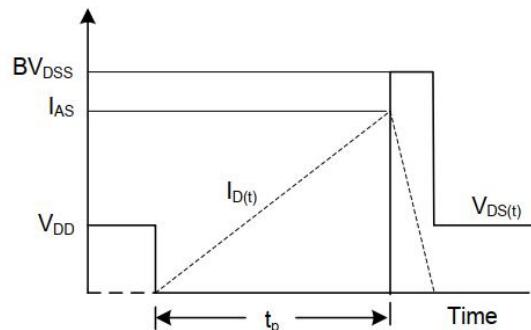
Gate Charge Test Circuit



Gate Charge Waveform



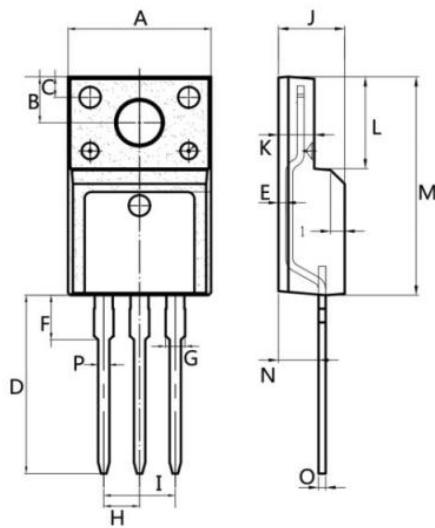
Unclamped Inductive Switching Test Circuit



Unclamped Inductive Switching Waveforms

## PACKAGE MECHANICAL DATA (Unit: mm):

TO-220F



| DIM | Min.     | Max.  |
|-----|----------|-------|
| A   | 9.9      | 10.3  |
| B   | 2.9      | 3.5   |
| C   | 1.15     | 1.45  |
| D   | 12.75    | 13.45 |
| E   | 0.55     | 0.75  |
| F   | 3.1      | 3.5   |
| G   | 1.25     | 1.45  |
| H   | Typ 2.54 |       |
| I   | Typ 5.08 |       |
| J   | 4.55     | 4.75  |
| K   | 2.4      | 2.7   |
| L   | 6.35     | 6.75  |
| M   | 15.0     | 16.0  |
| N   | 2.75     | 3.15  |
| O   | 0.45     | 0.60  |
| P   | 0.7      | 0.9   |

All Dimensions in millimeter

**Statement:**

- ◆ We reserve the right to change the manual without prior notice! Customers should obtain the latest version of the information before placing an order, and verify that the relevant information is complete and up-to-date.
- ◆ Any semiconductor product has the possibility of failure or failure under specific conditions. The buyer has the responsibility to comply with safety standards and take safety measures when using Silan product for system design and complete machine manufacturing, so as to avoid the occurrence of personal injury or property loss caused by potential failure risk!
- ◆ Product promotion will never end, our company will wholeheartedly provide customers with more excellent products!